

**Search Notes**

Application/Control No.

10/800,867

Examiner

Nguyen N. Hanh

Applicant(s)/Patent under  
Reexamination

TAKENAKA ET AL.

Art Unit

2834

**SEARCHED**

Class	Subclass	Date	Examiner
310	52	3/1/2006	HN
310	54	3/1/2006	HN
310	58	3/1/2006	HN
310	64	3/1/2006	HN
update Search	All	8/25/06	HN
update search	All	1/18/07	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
310	54	1/18/07	HN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PG Pub Text Search, see interference Search print out	1/18/07	HN
Consult Dang Le, Primary Examiner for Allowance	1/18/07	HN